



# N 沟道增强型场效应晶体管

## N-CHANNEL MOSFET

### FHN60N1F10LA

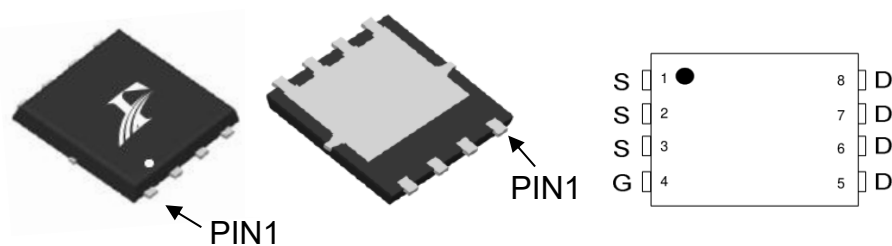
#### 主要参数 MAIN CHARACTERISTICS

ID	60A
VDSS	100 V
Rdson-typ ( @Vgs=10V)	10 mΩ
Rdson-typ ( @Vgs=4.5V)	12.5 mΩ
Qg-typ	33nC

#### 用途 APPLICATIONS

开关电源	Switching Power Supply
电机驱动	Motor Drive
同步整流	Synchronus Rectification

#### 封装形式 Package

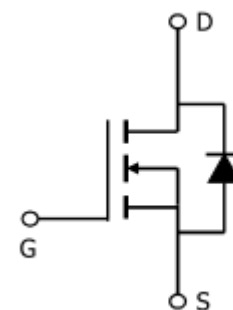


PDFN5X6-8  
FHN series

#### 产品特性 FEATURES

低栅极电荷	Low gate charge
低 Crss (典型值 11pF)	Low Crss (typical11pF)
开关速度快	Fast switching
100%经过雪崩测试	100% avalanche tested
100%经过热阻测试	100% dvds tested
100%经过 UIS 测试	100% UIS Tested
100%经过 RG 测试	100% Rg tested
RoHS 产品	RoHS product
SGT 工艺	SGT process

#### 等效电路 Equivalent Circuit



#### 绝对最大额定值 ABSOLUTE RATINGS (Tc=25°C)

项目 Parameter	符号 Symbol	数值 Value	单位 Unit
		FHN60N1F10LA	
最高漏极-源极直流电压 Drain-Source Voltage	V <sub>DS</sub>	100	V
连续漏极电流* Drain Current -continuous *	I <sub>D</sub> (T <sub>C</sub> =25°C)	60	A
	I <sub>D</sub> (T <sub>C</sub> =100°C)	47	A
最大脉冲漏极电流 (注 1) Drain Current – pulse (note 1)	I <sub>DM</sub>	240	A
最高栅源电压 Gate-Source Voltage	V <sub>GS</sub>	±20	V
单脉冲雪崩能量 (注 2) Single Pulsed Avalanche Energy (note 2)	E <sub>AS</sub>	56.25	mJ
雪崩电流 (注 1) Avalanche Current (note 1)	I <sub>AR</sub>	15	A
重复雪崩能量 (注 1) Repetitive Avalanche Current (note 1)	E <sub>AR</sub>	12	mJ
二极管反向恢复最大电压变化速率 (注 3) Peak Diode Recovery dv/dt (note 3)	dv/dt	5.0	V/ns
耗散功率 Power Dissipation	P <sub>D</sub> (T <sub>C</sub> =25°C)	56.5	W
	-Derate above 25°C	0.45	W/°C
最高结温及存储温度 Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55~+150	°C
引线最高焊接温度 Maximum Lead Temperature for Soldering Purposes	T <sub>L</sub>	260	°C

\*漏极电流由最高结温限制

\*Drain current limited by maximum junction temperature

## 电特性 ELECTRICAL CHARACTERISTICS

项目 Parameter	符号 Symbol	测试条件 Tests conditions	最小 Min	典型 Typ	最大 Max	单位 Units
<b>关态特性 Off –Characteristics</b>						
漏-源击穿电压 Drain-Source Voltage	BV <sub>DSS</sub>	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V	100	-	-	V
击穿电压温度特性 Breakdown Voltage Temperature Coefficient	ΔBV <sub>DSS</sub> /ΔT <sub>J</sub>	I <sub>D</sub> =250μA, referenced to 25°C	-	0.01	-	V/°C
零栅压下漏极漏电流 Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =100V, V <sub>GS</sub> =0V, T <sub>C</sub> =25°C	-	-	1	μA
		V <sub>DS</sub> =80V, T <sub>C</sub> =125°C	-	-	100	μA
栅极体漏电流 Gate-body leakage current	I <sub>GSS</sub> (F/R)	V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V	-	-	±100	nA
<b>通态特性 On-Characteristics</b>						
阈值电压 Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> =250μA	1.2	1.8	2.4	V
静态导通电阻 Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V , I <sub>D</sub> =20A	-	10	12	mΩ
		V <sub>GS</sub> =4.5V , I <sub>D</sub> =20A	-	12.5	15.5	mΩ
正向跨导 Forward Transconductance	g <sub>fs</sub>	V <sub>DS</sub> = 5V, I <sub>D</sub> =20A (note 4)	-	60	-	S
<b>动态特性 Dynamic Characteristics</b>						
栅电阻 Gate Resistance	R <sub>g</sub>	f=1.0MHz, V <sub>DS</sub> =OPEN	-	1.8	-	Ω
输入电容 Input capacitance	C <sub>iss</sub>	V <sub>DS</sub> =50V, V <sub>GS</sub> =0V, f=1.0MHz	-	2420	-	pF
输出电容 Output capacitance	C <sub>oss</sub>		-	170	-	
反向传输电容 Reverse transfer capacitance	C <sub>rss</sub>		-	11	-	
<b>开关特性 Switching Characteristics</b>						
延迟时间 Turn-On delay time	t <sub>d(on)</sub>	V <sub>DD</sub> =50V, I <sub>D</sub> =20A, R <sub>G</sub> =3Ω V <sub>GS</sub> =10V (note 4, 5)	-	8	-	ns
上升时间 Turn-On rise time	t <sub>r</sub>		-	3	-	ns
延迟时间 Turn-Off delay time	t <sub>d(off)</sub>		-	25	-	ns
下降时间 Turn-Off Fall time	t <sub>f</sub>		-	4	-	ns
栅极电荷总量 Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> =50V , I <sub>D</sub> =20A , V <sub>GS</sub> =10V (note 4, 5)	-	33	-	nC
栅-源电荷 Gate-Source charge	Q <sub>gs</sub>		-	7	-	nC
栅-漏电荷 Gate-Drain charge	Q <sub>gd</sub>		-	12	-	nC
<b>漏-源二极管特性及最大额定值 Drain-Source Diode Characteristics and Maximum Ratings</b>						
正向最大连续电流 Maximum Continuous Drain - Source Diode Forward Current		I <sub>S</sub>	-	-	60	A
正向最大脉冲电流 Maximum Pulsed Drain-Source Diode Forward Current		I <sub>SM</sub>	-	-	240	A
正向压降 Drain-Source Diode Forward Voltage	V <sub>SD</sub>	V <sub>GS</sub> =0V, I <sub>S</sub> =20A	-	0.91	1.2	V
反向恢复时间 Reverse recovery time	t <sub>rr</sub>	V <sub>GS</sub> =0V, I <sub>S</sub> =20A, dI <sub>F</sub> /dt=500A/μs (note 4)	-	27	-	ns
反向恢复电荷 Reverse recovery charge	Q <sub>rr</sub>		-	128	-	nC

## 热特性 THERMAL CHARACTERISTIC

项目 Parameter	符号 Symbol	FHN60N1F10LA	单位 Unit
结到管壳的热阻 Thermal Resistance, Junction to Case	Rth(j-c)	2.12	°C/W
结到环境的热阻 Thermal Resistance, Junction to Ambient	Rth(j-A)	50	°C/W

### 注释:

- 1: 脉冲宽度由最高结温限制
- 2: L=0.5mH, V<sub>G</sub>=10V, V<sub>DD</sub>=50V, R<sub>G</sub>=25 Ω, 起始结温 T<sub>J</sub>=25°C
- 3: I<sub>SD</sub> ≤60A, di/dt ≤300A/μs, V<sub>DD</sub> ≤BV<sub>DSS</sub>, 起始结温 T<sub>J</sub>=25°C
- 4: 脉冲测试: 脉冲宽度 ≤300μs, 占空比 ≤2%
- 5: 基本与工作温度无关

### Notes:

- 1: Pulse width limited by maximum junction temperature
- 2: L=0.5mH, V<sub>G</sub>=10V, V<sub>DD</sub>=50V, R<sub>G</sub>=25 Ω, Starting T<sub>J</sub>=25°C
- 3: I<sub>SD</sub> ≤60A, di/dt ≤300A/μs, V<sub>DD</sub> ≤BV<sub>DSS</sub>, Starting T<sub>J</sub>=25°C
- 4: Pulse Test: Pulse Width ≤300μs, Duty Cycle ≤2%
- 5: Essentially independent of operating temperature

## Typical Operating Characteristics

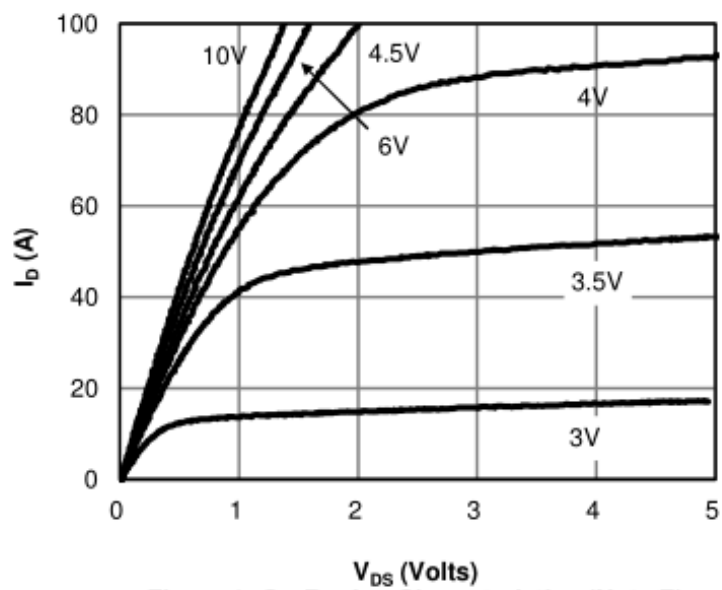


Figure 1: On-Region Characteristics (Note E)

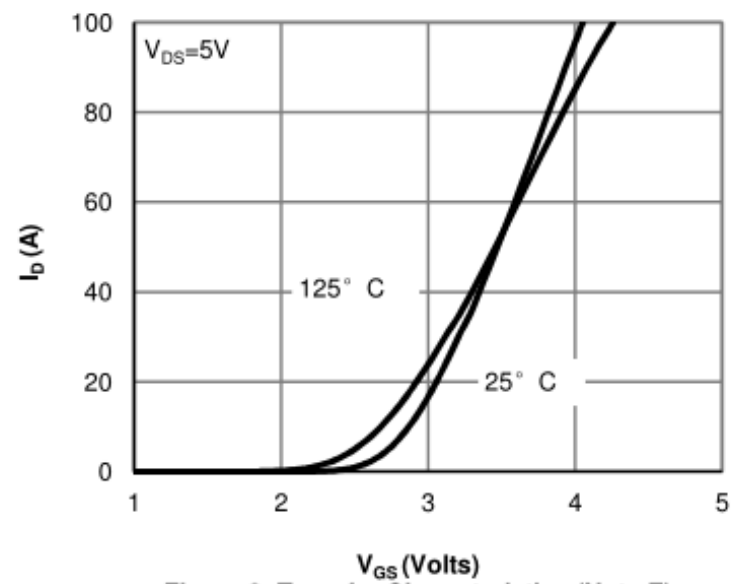


Figure 2: Transfer Characteristics (Note E)

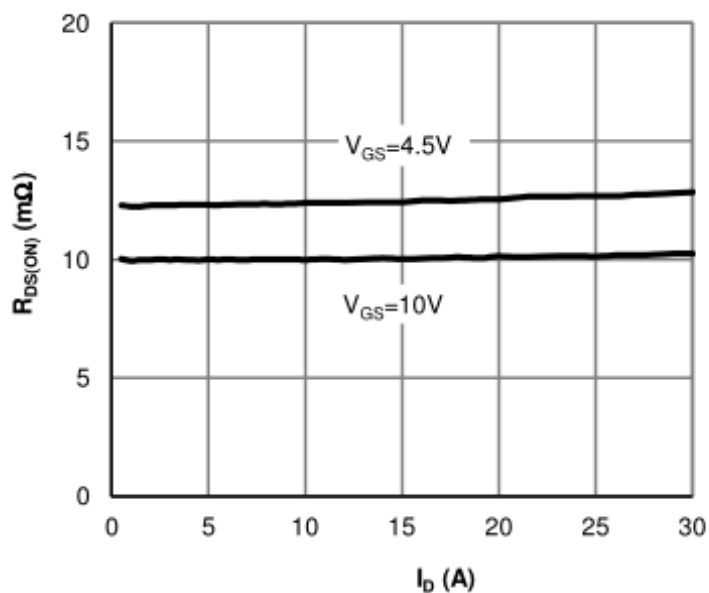


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

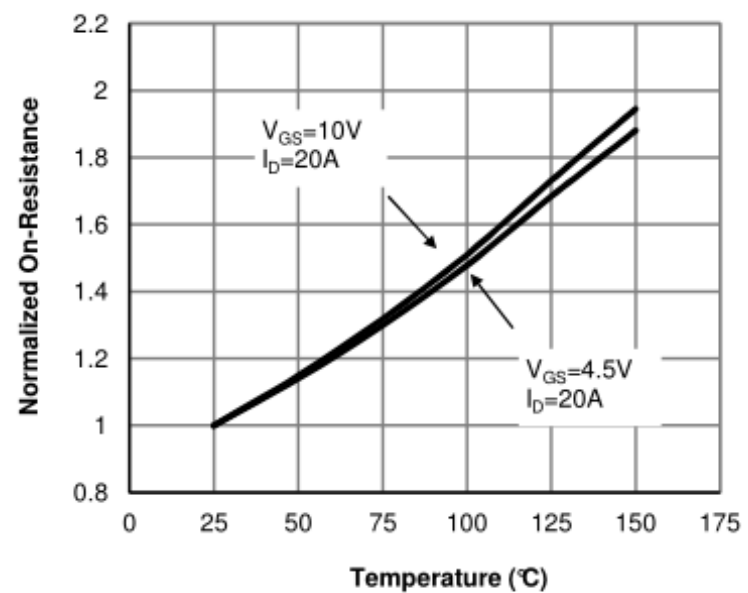


Figure 4: On-Resistance vs. Junction Temperature (Note E)

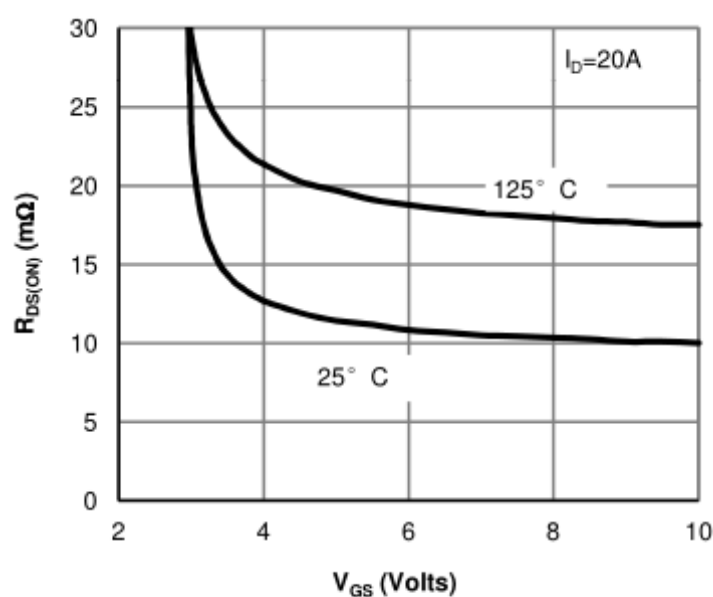


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

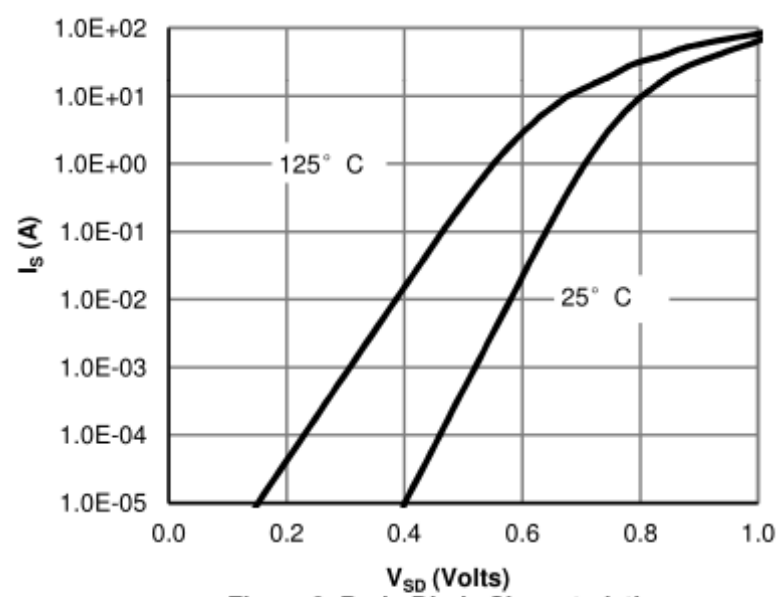


Figure 6: Body-Diode Characteristics (Note E)

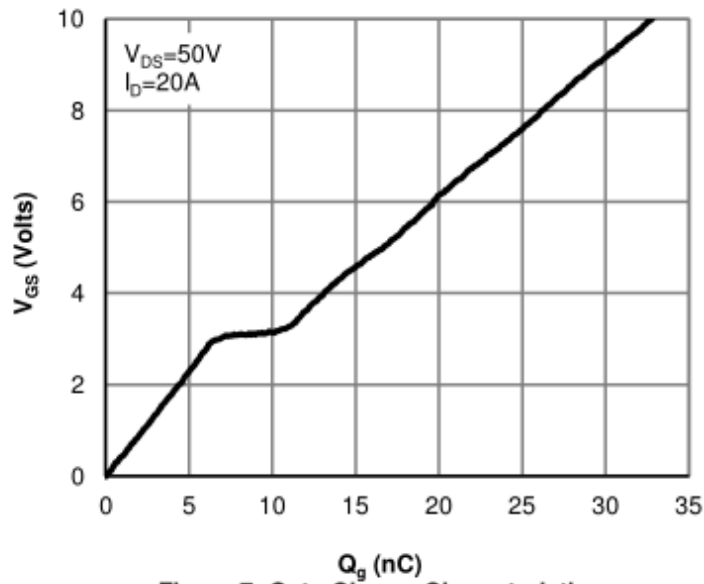


Figure 7: Gate-Charge Characteristics

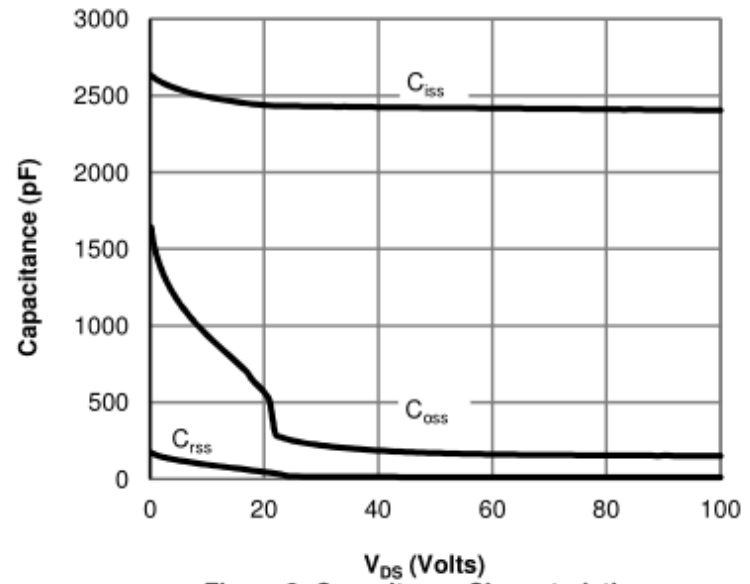


Figure 8: Capacitance Characteristics

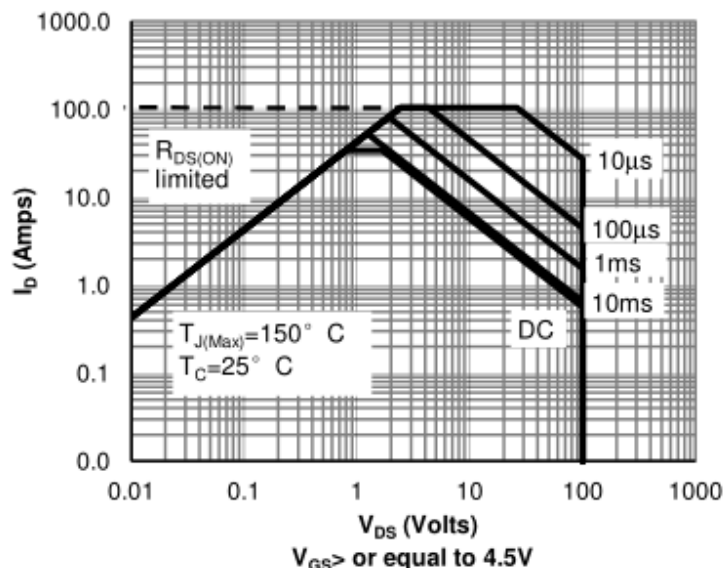


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

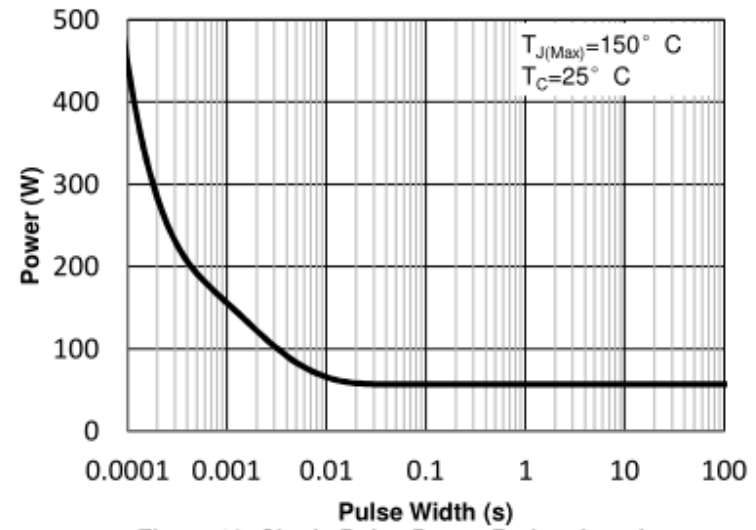


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

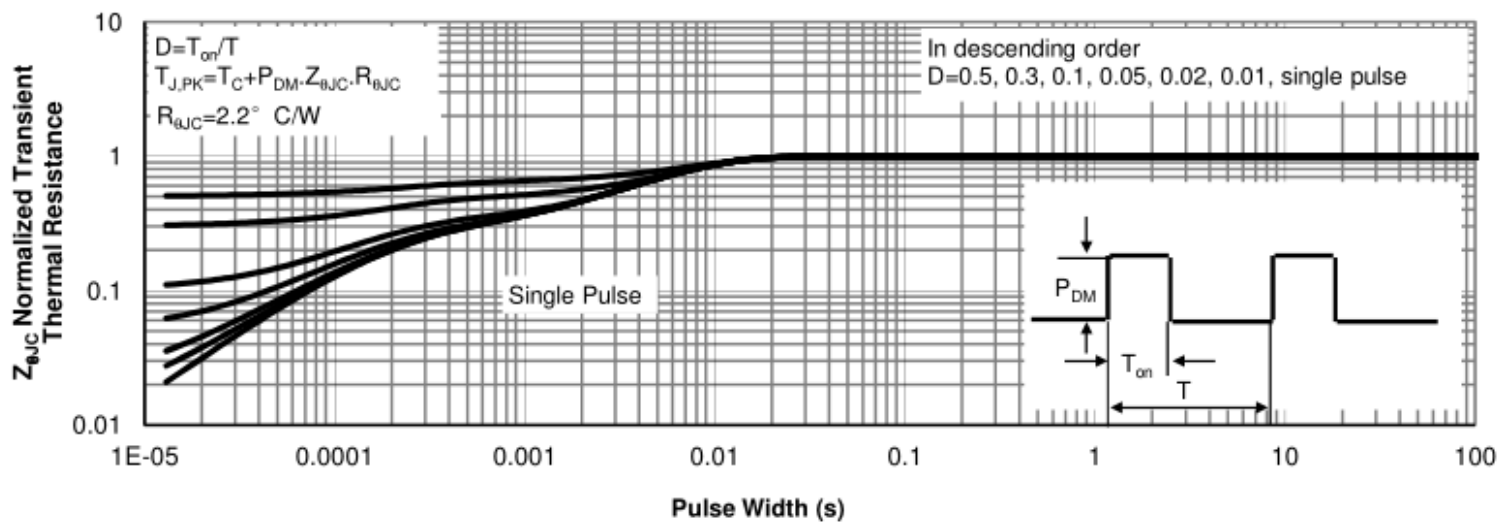


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

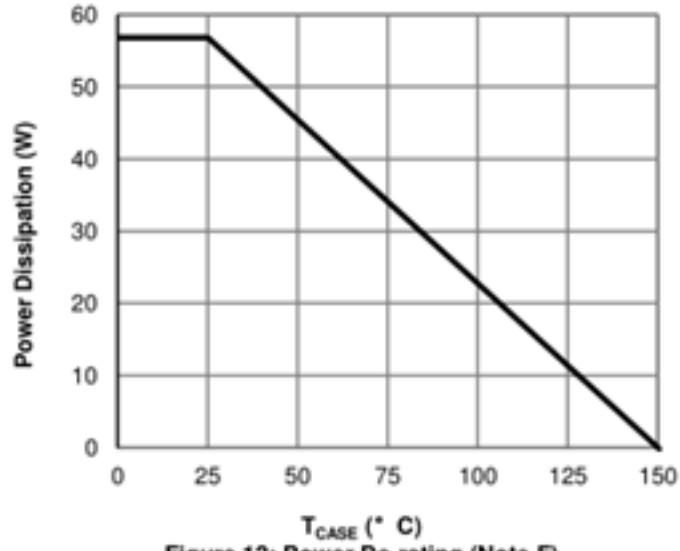


Figure 12: Power De-rating (Note F)

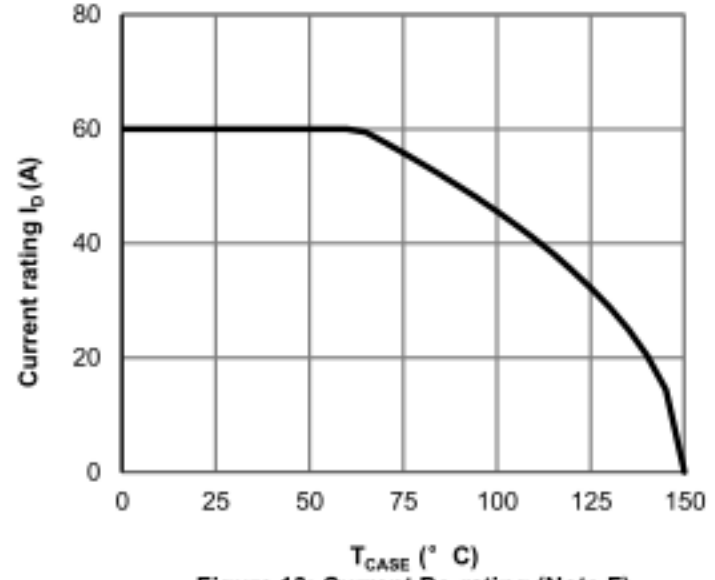


Figure 13: Current De-rating (Note F)

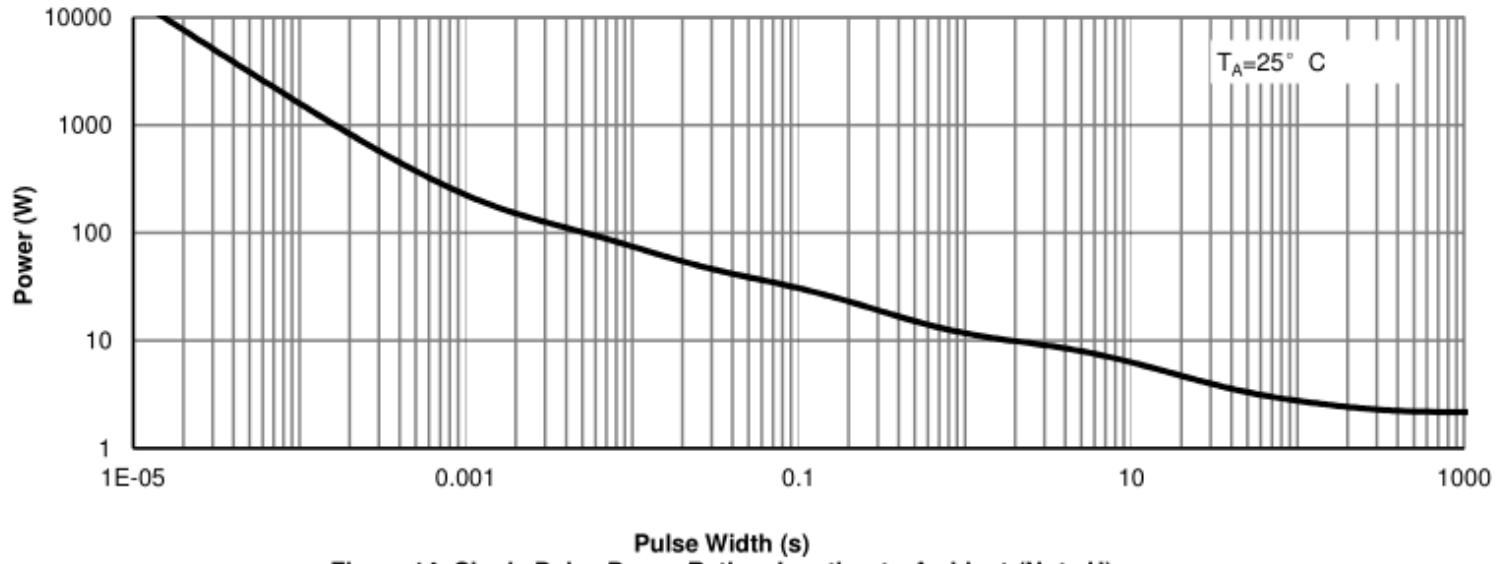


Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

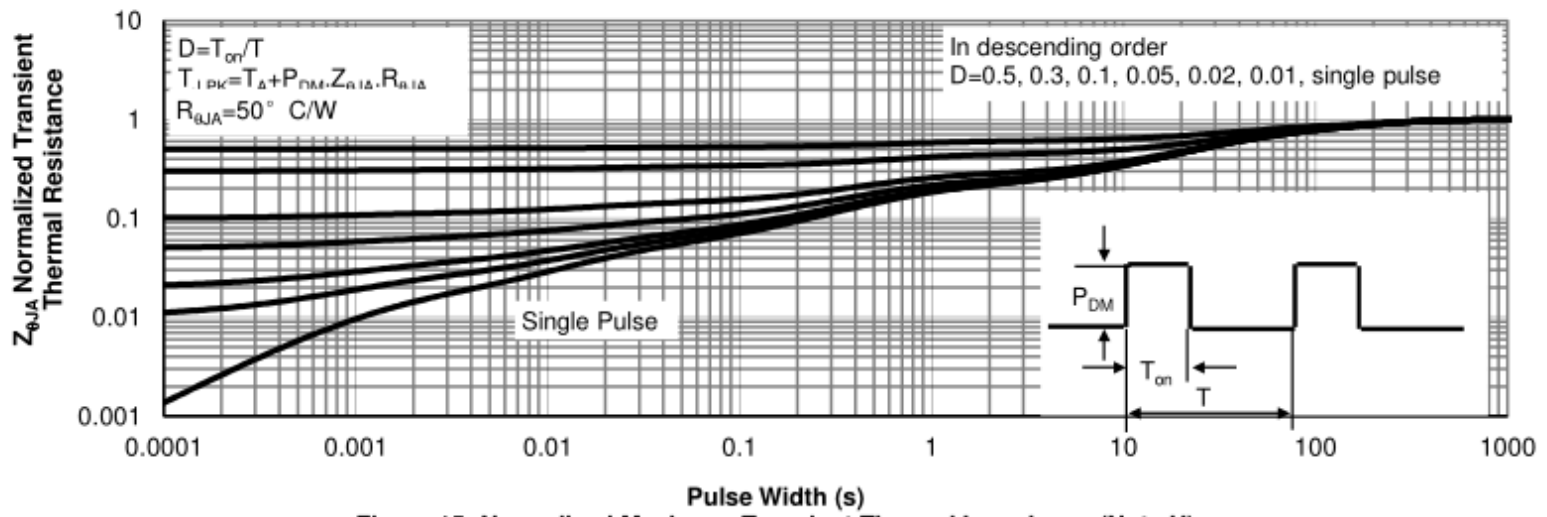
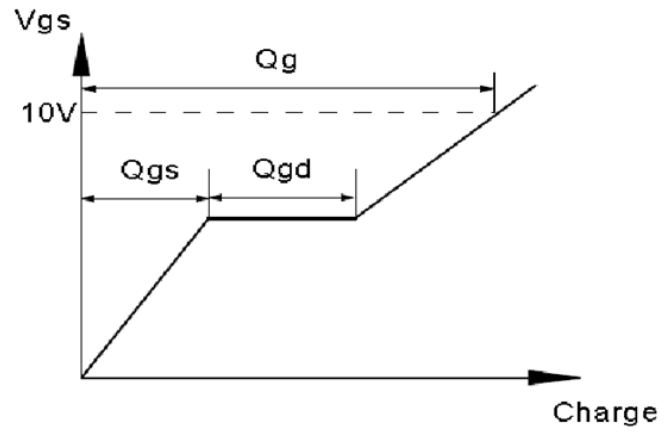
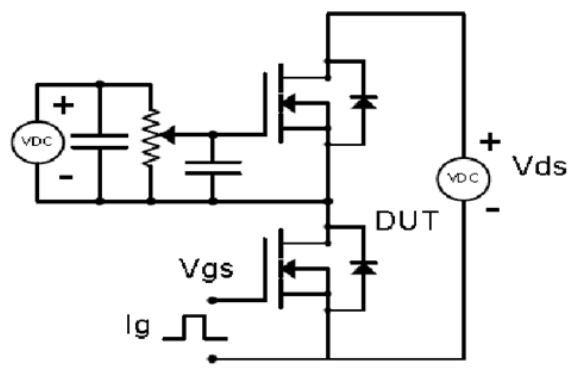


Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

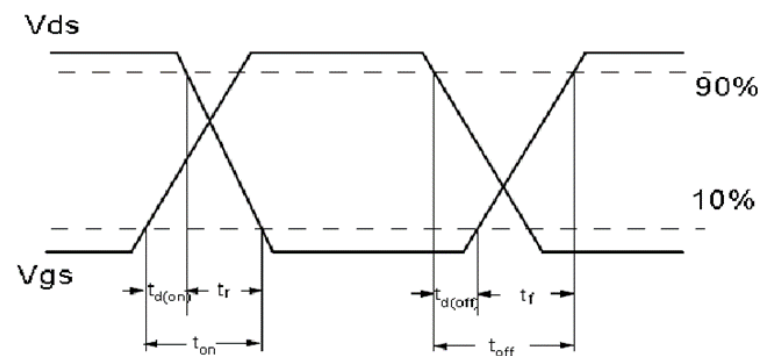
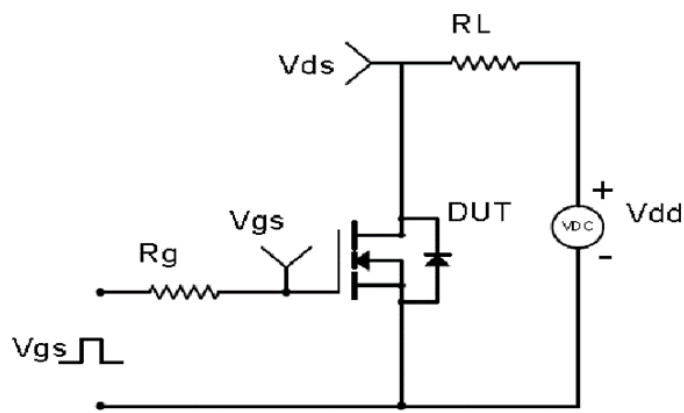
# Test Circuit & Waveform

## Gate Charge Test Circuit & Waveform

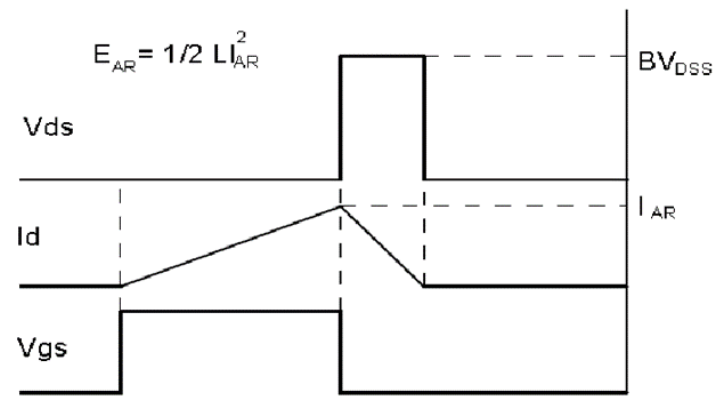
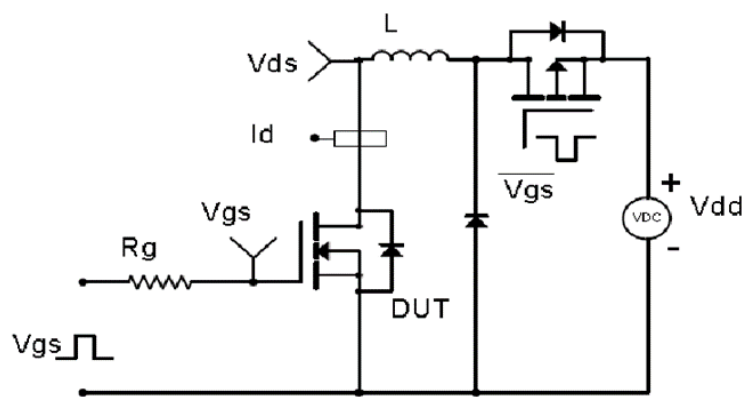


## Resistive Switching Test Circuit & Waveforms

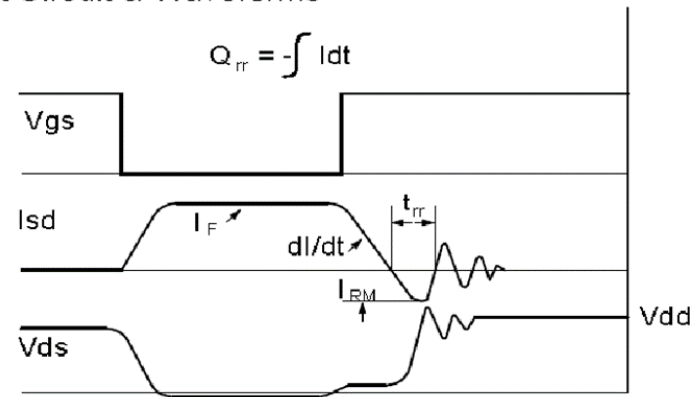
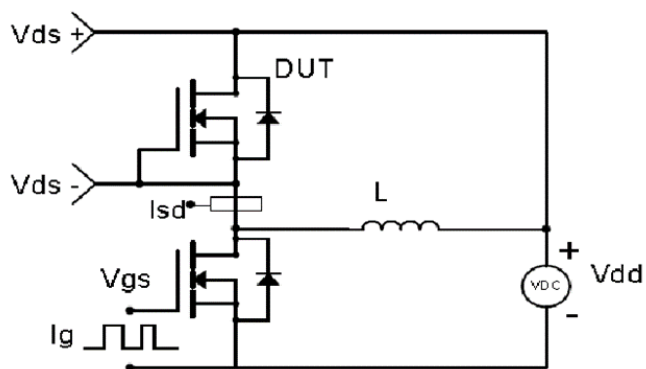
### Resistive Switching Test Circuit & Waveforms



### Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

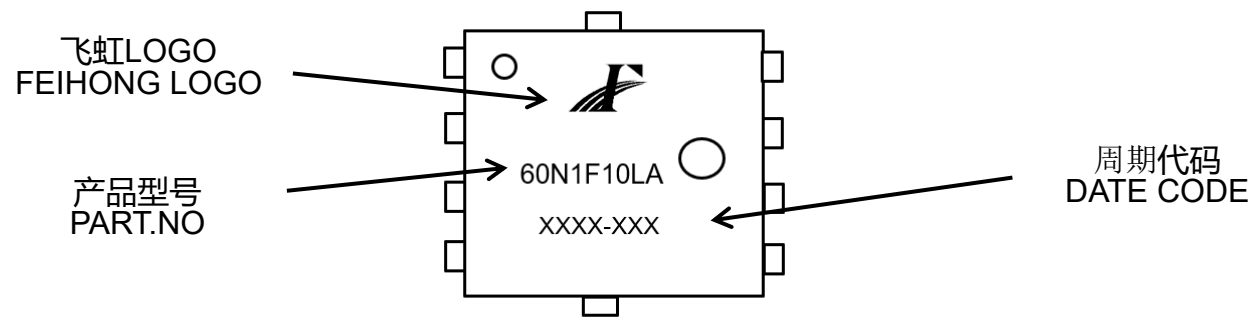


### Diode Recovery Test Circuit & Waveforms



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印记 Marking:

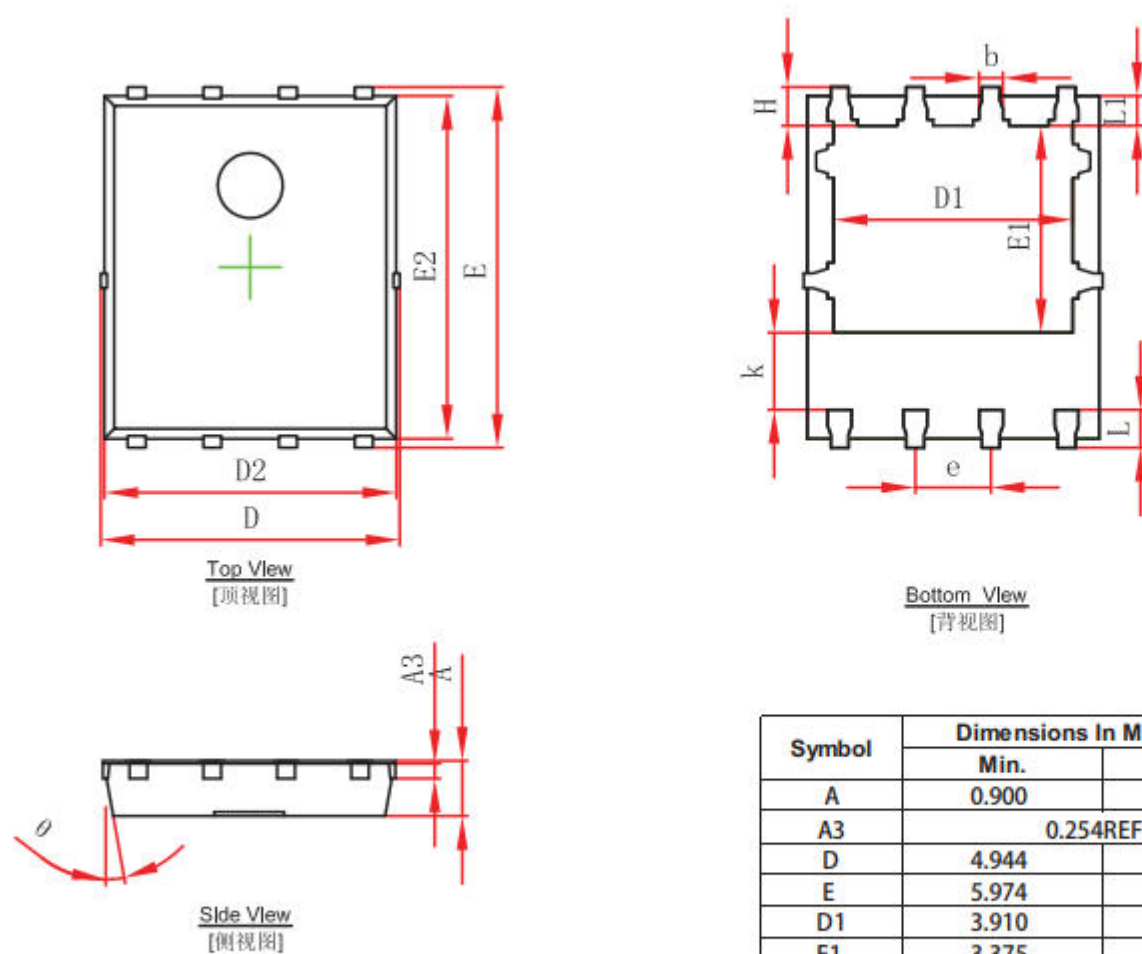




外形尺寸:

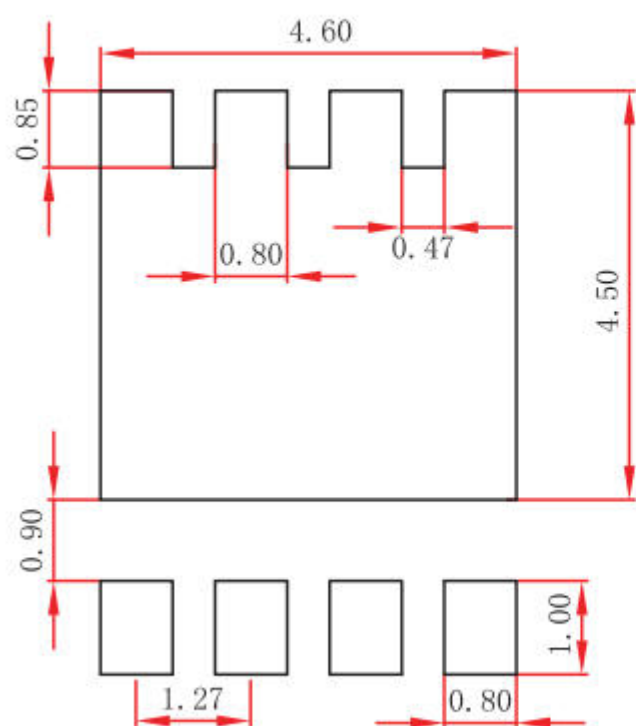
## PDNF5X6-8

### Package Outline Dimensions



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.900	1.000	0.035	0.039
A3	0.254REF.		0.010REF.	
D	4.944	5.096	0.195	0.201
E	5.974	6.126	0.235	0.241
D1	3.910	4.110	0.154	0.162
E1	3.375	3.575	0.133	0.141
D2	4.824	4.976	0.190	0.196
E2	5.674	5.826	0.223	0.229
k	1.190	1.390	0.047	0.055
b	0.350	0.450	0.014	0.018
e	1.270TYP.		0.050TYP.	
L	0.559	0.711	0.022	0.028
L1	0.424	0.576	0.017	0.023
H	0.574	0.726	0.023	0.029
θ	10°	12°	10°	12°

### Suggested Pad Layout



Note:

1. Controlling dimension: in millimeters.
2. General tolerance:  $\pm 0.05\text{mm}$ .
3. The pad layout is for reference purposes only.